MOSFET - Power, Single, N-Channel, SO-8 FL 30 V, 100 A

- Low R_{DS(on)} to Minimize Conduction Losses
- Low Capacitance to Minimize Driver Losses
- Optimized Gate Charge to Minimize Switching Losses
- Thermally Enhanced SO8 Package
- These are Pb-Free Device

Applications

- CPU Power Delivery
- DC-DC Converters
- Low Side Switching

MAXIMUM RATINGS (T_J = 25°C unless otherwise stated)

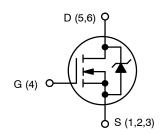
Parameter			Symbol	Value	Unit
Drain-to-Source Voltage			V_{DSS}	30	V
Gate-to-Source Vol	tage		V_{GS}	±20	V
Continuous Drain Current R _{0JA}		T _A = 25°C	Ι _D	20.3	Α
(Note 1)		T _A = 85°C		14.6	
Power Dissipation $R_{\theta JA}$ (Note 1)		T _A = 25°C	P_{D}	2.25	V
Continuous Drain		$T_A = 25^{\circ}C$	I _D	32.8	Α
Current R _{θJA} ≤ 10 sec		T _A = 85°C		23.7	
Power Dissipation $R_{\theta JA,} t \leq 10 \text{ sec}$	Steady	T _A = 25°C	P _D	5.90	W
Continuous Drain	State	T _A = 25°C	I _D	12.7	Α
Current R _{θJA} (Note 2)		T _A = 85°C		9.2	
Power Dissipation $R_{\theta JA}$ (Note 2)		T _A = 25°C	P _D	0.89	W
Continuous Drain		T _C = 25°C	Ι _D	100	Α
Current R _{θJC} (Note 1)		T _C = 85°C		72	
Power Dissipation $R_{\theta JC}$ (Note 1)		T _C = 25°C	P _D	55.5	W
Pulsed Drain Current	t _p =10μs	T _A = 25°C	I _{DM}	200	Α
Current limited by package $T_A = 25^{\circ}C$			I _{Dmaxpkg}	100	Α
Operating Junction and Storage Temperature		T _J , T _{STG}	-55 to +150	°C	
Source Current (Body Diode)			I _S	55	Α
Drain to Source dV/dt			dV/dt	6	V/ns



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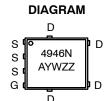
V _{(BR)DSS}	R _{DS(ON)} MAX	I _D MAX
30 V	3.4 mΩ @ 10 V	
30 V	5.1 mΩ @ 4.5 V	100 A



N-CHANNEL MOSFET



CASE 488AA STYLE 1



MARKING

Α = Assembly Location

W = Work Week ZZ = Lot Traceability

ORDERING INFORMATION

Device	Package	Shipping [†]
NTMFS4946NT1G	SO-8FL (Pb-Free)	1500 / Tape & Reel
NTMFS4946NT3G	SO-8FL (Pb-Free)	5000 / Tape & Reel

[†]For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.

MAXIMUM RATINGS ($T_J = 25^{\circ}C$ unless otherwise stated)

Parameter	Symbol	Value	Unit
Single Pulse Drain-to-Source Avalanche Energy (V_{DD} = 50 V, V_{GS} = 10 V, I_L = 37 A_{pk} , L = 0.3 mH, R_G = 25 Ω)	EAS	205	mJ
Lead Temperature for Soldering Purposes (1/8" from case for 10 s)	TL	260	°C

Stresses exceeding Maximum Ratings may damage the device. Maximum Ratings are stress ratings only. Functional operation above the Recommended Operating Conditions is not implied. Extended exposure to stresses above the Recommended Operating Conditions may affect device reliability.

THERMAL RESISTANCE MAXIMUM RATINGS

Parameter	Symbol	Value	Unit
Junction-to-Case (Drain)	$R_{ heta JC}$	2.25	
Junction-to-Ambient - Steady State (Note 1)	$R_{\theta JA}$	55.6	°C/W
Junction-to-Ambient - Steady State (Note 2)	$R_{\theta JA}$	140.8	°C/VV
Junction-to-Ambient - t ≤ 10 sec	$R_{ heta JA}$	21.2	

- Surface-mounted on FR4 board using 1 sq-in pad, 1 oz Cu.
 Surface-mounted on FR4 board using the minimum recommended pad size.

FLECTRICAL CHARACTERISTICS (T. - 25°C unless otherwise specified)

Parameter	Symbol	Test Condition		Min	Тур	Max	Unit
OFF CHARACTERISTICS							
Drain-to-Source Breakdown Voltage	V _{(BR)DSS}	$V_{GS} = 0 \text{ V}, I_D = 250 \mu\text{A}$		30			V
Drain-to-Source Breakdown Voltage Temperature Coefficient	V _{(BR)DSS} /				25		mV/°C
Zero Gate Voltage Drain Current	I _{DSS}	V _{GS} = 0 V, T _J = 25 °C				1	,
		V _{DS} = 24 V	T _J = 125°C			10	μΑ
Gate-to-Source Leakage Current	I _{GSS}	$V_{DS} = 0 \text{ V}, V_{GS}$	= ±20 V			±100	nA
ON CHARACTERISTICS (Note 3)							
Gate Threshold Voltage	V _{GS(TH)}	$V_{GS} = V_{DS}, I_D$	= 250 μΑ	1.45	1.8	2.5	V
Negative Threshold Temperature Coefficient	V _{GS(TH)} /T _J	_			5.2		mV/°C
Drain-to-Source On Resistance	R _{DS(on)}	V _{GS} = 10 V to 11.5 V V _{GS} = 4.5 V	I _D = 30 A		2.5	3.4	
			I _D = 15 A		2.4		
			I _D = 30 A		3.8	5.1	mΩ
			I _D = 15 A		3.8		
Forward Transconductance	9FS	V _{DS} = 1.5 V, I _D = 30 A			85		S
CHARGES AND CAPACITANCES							
Input Capacitance	C _{ISS}				3250		
Output Capacitance	C _{OSS}	V _{GS} = 0 V, f = 1 MH	z, V _{DS} = 12 V		562		pF
Reverse Transfer Capacitance	C _{RSS}				289		
Total Gate Charge	$Q_{G(TOT)}$				21.8	32	
Threshold Gate Charge	Q _{G(TH)}	V 45VV	T. \		3.2		0
Gate-to-Source Charge	Q_{GS}	$V_{GS} = 4.5 \text{ V}, V_{DS} = 1$	15 V; I _D = 30 A		8.1		nC
Gate-to-Drain Charge	Q_{GD}	1			7.4		1
Total Gate Charge	Q _{G(TOT)}	V _{GS} = 11.5 V, V _{DS} = 15 V, I _D = 30 A			53		nC
SWITCHING CHARACTERISTICS (Note 4)	-			ā.	-	<u>-</u>	-
Turn-On Delay Time	t _{d(ON)}				18.9		
Rise Time	t _r	VG9 = 4.5 V. VD9 = 1	5 V. In = 15 A.		34		1
		V_{GS} = 4.5 V, V_{DS} = 15 V, I_D = 15 A, R_G = 3.0 Ω					ns

3. Pulse Test: pulse width \leq 300 μ s, duty cycle \leq 2%.

Fall Time

4. Switching characteristics are independent of operating junction temperatures.

ELECTRICAL CHARACTERISTICS (T_J = 25°C unless otherwise specified)

Parameter	Symbol	Test Condition		Min	Тур	Max	Unit
SWITCHING CHARACTERISTICS (N	ote 4)			•	•		
Turn-On Delay Time	t _{d(ON)}				10.7		
Rise Time	t _r	V_{GS} = 11.5 V, V_{DS} = 15 V, I_{D} = 15 A, R_{G} = 3.0 Ω			18.9		
Turn-Off Delay Time	t _{d(OFF)}	$I_D = 15 A, R_G$	$= 3.0 \Omega$		34.2		ns
Fall Time	t _f				7.1		
DRAIN-SOURCE DIODE CHARACT	ERISTICS						
Forward Diode Voltage	V _{SD}	V _{GS} = 0 V, I _S = 30 A	T _J = 25°C		8.0	1.0	.,
			T _J = 125°C		0.66		V
Reverse Recovery Time	t _{RR}		•		21.6		
Charge Time	t _a	$V_{GS} = 0 \text{ V, } dI_{S}/dt = 100 \text{ A}/\mu\text{s,}$ $I_{S} = 30 \text{ A}$			11.4		ns
Discharge Time	t _b				10.2		
Reverse Recovery Charge	Q_{RR}				8.5		nC
PACKAGE PARASITIC VALUES				-			
Source Inductance	L _S				0.65		nH
Drain Inductance	L _D	T _A = 25°C			0.005		
Gate Inductance	L _G				1.84		
Gate Resistance	R_{G}			0.5	1.4	2.2	Ω

^{3.} Pulse Test: pulse width \leq 300 μ s, duty cycle \leq 2%.

TYPICAL CHARACTERISTICS

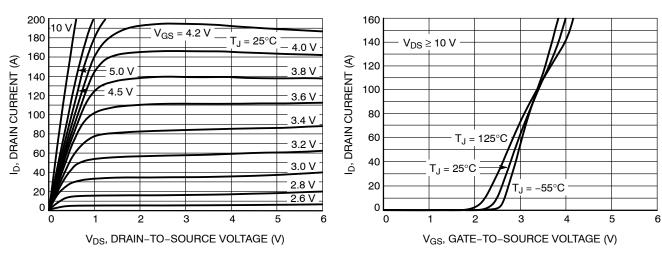


Figure 1. On-Region Characteristics

Figure 2. Transfer Characteristics

TYPICAL CHARACTERISTICS

^{4.} Switching characteristics are independent of operating junction temperatures.

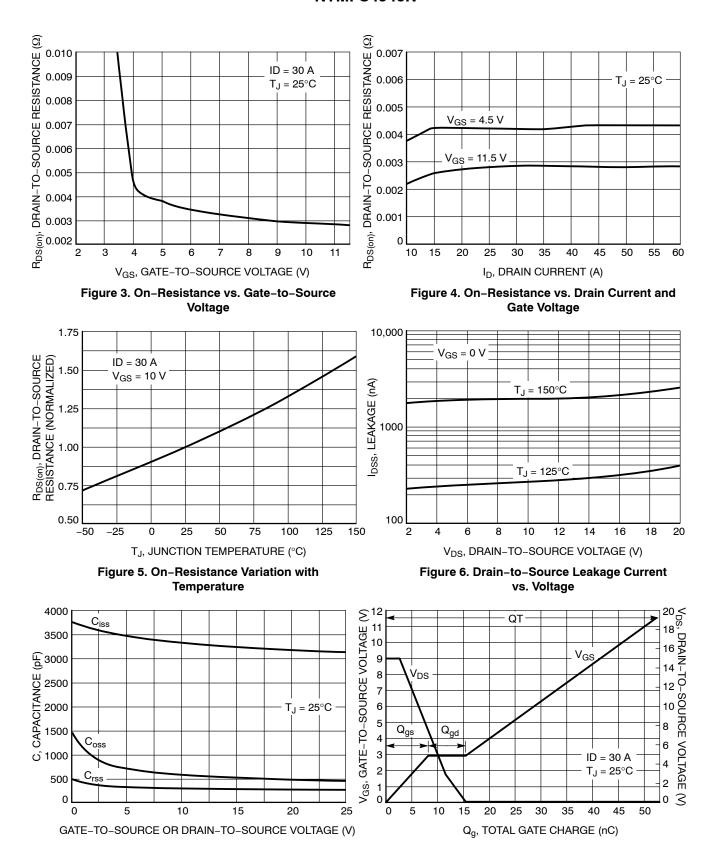


Figure 7. Capacitance Variation

Figure 8. Gate-to-Source and Drain-to-Source Voltage vs. Total Charge

TYPICAL CHARACTERISTICS

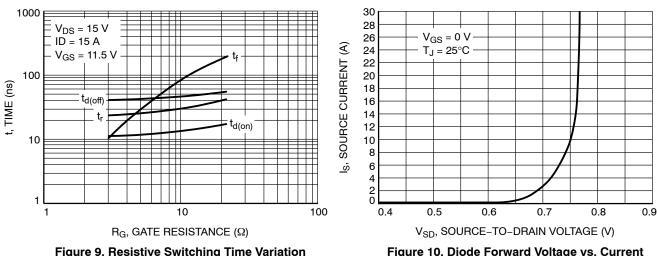


Figure 9. Resistive Switching Time Variation vs. Gate Resistance

Figure 10. Diode Forward Voltage vs. Current

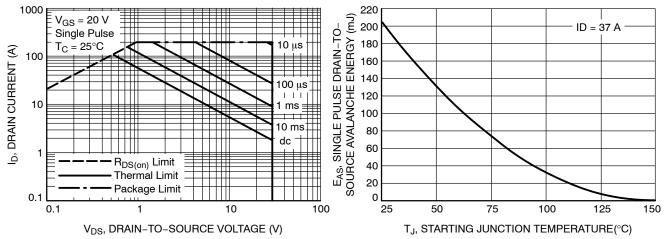


Figure 11. Maximum Rated Forward Biased Safe Operating Area

Figure 12. Maximum Avalanche Energy vs. **Starting Junction Temperature**

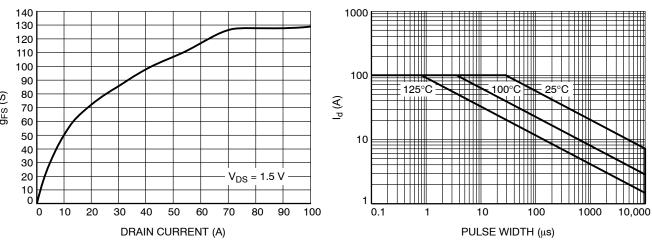


Figure 13. g_{FS} vs. Drain Current

Figure 14. I_d vs. Pulse Width



0.10

0.10

SIDE VIEW

DFN5 5x6, 1.27P (SO-8FL) CASE 488AA ISSUE N

DATE 25 JUN 2018

NOTES:

BURRS

- DIMENSIONING AND TOLERANCING PER
- ASME Y14.5M, 1994. CONTROLLING DIMENSION: MILLIMETER. DIMENSION D1 AND E1 DO NOT INCLUDE MOLD FLASH PROTRUSIONS OR GATE

	MILLIMETERS					
DIM	MIN	NOM	MAX			
Α	0.90	1.00	1.10			
A1	0.00		0.05			
b	0.33	0.41	0.51			
С	0.23	0.28	0.33			
D	5.00	5.15	5.30			
D1	4.70	4.90	5.10			
D2	3.80	4.00	4.20			
E	6.00	6.15	6.30			
E1	5.70	5.90	6.10			
E2	3.45	3.65	3.85			
е		1.27 BSC	;			
G	0.51	0.575	0.71			
K	1.20	1.35	1.50			
L	0.51	0.575	0.71			
L1	0.125 REF					
М	3.00	3.40	3.80			
A	0 0		12 °			

GENERIC MARKING DIAGRAM*



XXXXXX = Specific Device Code

= Assembly Location Α

Υ = Year W = Work Week ZZ = Lot Traceability

*This information is generic. Please refer to device data sheet for actual part marking. Pb-Free indicator, "G" or microdot " ■", may or may not be present. Some products may not follow the Generic Marking.





DETAIL A

*For additional information on our Pb-Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

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DESCRIPTION:	DFN5 5x6, 1.27P (SO-8FL)		PAGE 1 OF 1	

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